Se	earch	Note:	S

Application/Control No.	Applicant(s)/Patent under Reexamination	,
09/804,244	KATO ET AL.	
Examiner	· Art Unit	
J. Derek Rutten	2192	

SEARCHED			
Class	Subclass	Date	Examiner
717	162-167	7/15/2005	JDR
	,		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	-0.		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (attached)	7/15/2005	JDR
		<u>. </u>